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Fairchild Semiconductor FDD6672A

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Distributor of Fairchild Semiconductor: Excellent Integrated System Limited Datasheet of FDD6672A - MOSFET N-CH 30V 65A D-PAK Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

FAIRCHILD

SEMICONDUCTOR

FDD6672A

30V N-Channel PowerTrench[®] MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $R_{DS(ON)}$ and fast switching speed.

Applications

DC/DC converter

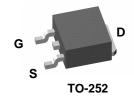
Features

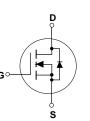
• 65 A, 30 V. $\begin{array}{l} {\sf R}_{{\sf DS}({\sf ON})} \, = 9.5 \; m\Omega \, @ \; {\sf V}_{{\sf GS}} = 4.5 \; {\sf V} \\ {\sf R}_{{\sf DS}({\sf ON})} \, = 8 \; m\Omega \, @ \; {\sf V}_{{\sf GS}} = 10 \; {\sf V} \end{array}$

FDD6672A

April 2001

- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low gate charge (33 nC typical)
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Source Voltage			30	V
V _{GSS}	Gate-Source Voltage			±12	V
I _D	Drain Current – Continuous (Note 1a)			65	А
		- Pulsed		100	
P _D	Maximum F	Power Dissipation @ T _c =	: 25°C (Note 1)	70	W
		@ T _A =	25°C (Note 1a)	3.2	
		@ T _A =	25°C (Note 1b)	1.3	
T _J , T _{STG}	Operating a	and Storage Junction Ten	nperature Range	-55 to +150	°C
	Thermal Re	teristics esistance, Junction-to-Cas	Se (Note 1)	1.8	°C/W
R _{θJC}	Thermal Re		. ,	1.8 96	
R _{ejc} R _{ejA} Packag	Thermal Re Thermal Re	esistance, Junction-to-Cas	bient (Note 1b)		°C/W ○C/W

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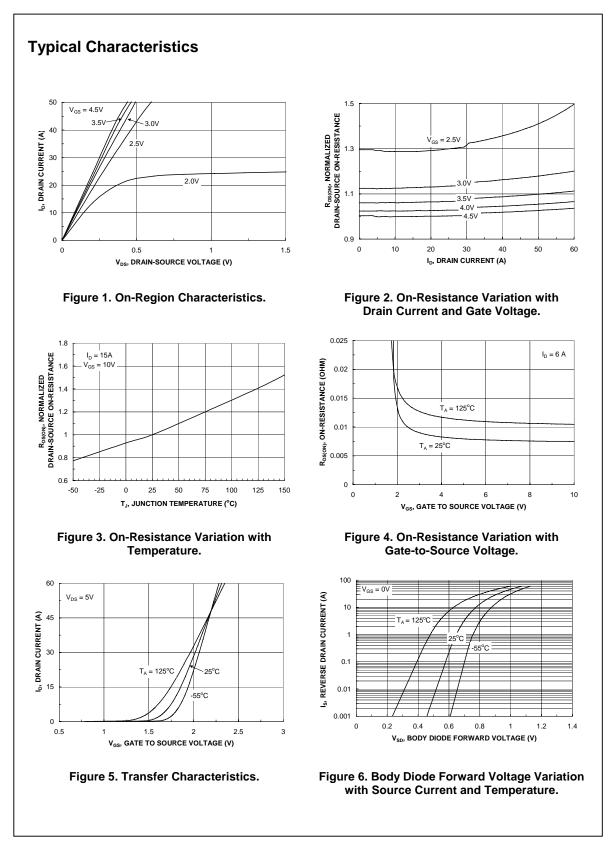


cteristics Drain–Source Breakdown Voltage					
Drain-Source Breakdown Voltage					
	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V
Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25° C		20		mV/°C
Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			1	μΑ
Gate–Body Leakage, Forward	$V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
Gate–Body Leakage, Reverse $V_{GS} = -12 V V_{DS} = 0 V$				-100	nA
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.8	1.2	2.0	V
Gate Threshold Voltage	I_D = 250 µA, Referenced to 25°C		-4		mV/°C
Static Drain–Source Dn–Resistance	$V_{GS} = 4.5 V, I_D = 13 A$ $V_{GS} = 4.5 V, I_D = 13 A, T_J=125^{\circ}C$ $V_{GS} = 10 V, I_D = 14 A$		8.2 11.5 6.8	9.5 16 8	mΩ
Dn-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	50			A
Forward Transconductance	$V_{DS} = 10 V$, $I_D = 15 A$		75		S
Characteristics					
nput Capacitance	$V_{DS} = 15 V_{c} V_{cS} = 0 V_{c}$		5070		pF
Dutput Capacitance	f = 1.0 MHz		550		, pF
Reverse Transfer Capacitance	1		230		pF
Characteristics (Nate 2)	ł	L	L		
	$V_{DD} = 10 V$, $I_D = 1 A$,		17	25	ns
,	$V_{GS} = 4.5 V, R_{GEN} = 6 \Omega$				ns
	-		69	100	ns
,	-		29	42	ns
	$V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$		33	46	nC
	V _{GS} = 4.5 V		7.5		nC
Gate–Drain Charge			6.8		nC
Irce Diode Characteristics	and Maximum Ratings				
				2.7	А
Drain-Source Diode Forward	$V_{GS} = 0 V$, $I_S = 2.7 A$ (Note 2)		0.7	1.2	V
	Cero Gate Voltage Drain Current Gate-Body Leakage, Forward Gate-Body Leakage, Reverse Cteristics (Note 2) Gate Threshold Voltage Gate Drain Current forward Transconductance Duput Capacitance Duput Capacitance Characteristics (Note 2) furn-On Delay Time furn-On Rise Time furn-Off Fall Time fotal Gate Charge Gate-Source Charge Gate-Drain Charge Gate-Drain Charge Maximum Continuous Drain-Source	ConstructionV_{DS} = 24 V, V_{GS} = 0 VCero Gate Voltage Drain Current $V_{DS} = 24 V$, $V_{DS} = 0 V$ Sate-Body Leakage, Forward $V_{GS} = 12 V$, $V_{DS} = 0 V$ Cate-Body Leakage, Reverse $V_{GS} = -12 V V_{DS} = 0 V$ Sate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ Sate Threshold Voltage $I_D = 250 \mu A$, Referenced to 25°Cemperature Coefficient $I_D = 250 \mu A$, Referenced to 25°CSate Threshold Voltage $V_{DS} = 4.5 V$, $I_D = 13 A$ Dn-Resistance $V_{GS} = 4.5 V$, $I_D = 13 A$, $T_J = 125°C$ $V_{CS} = 10 V$, $I_D = 14 A$ $V_{DS} = 10 V$, $I_D = 14 A$ Dn-State Drain Current $V_{GS} = 10 V$, $V_{DS} = 5 V$ Forward Transconductance $V_{DS} = 10 V$, $I_D = 15 A$ Characteristics $V_{DS} = 10 V$, $I_D = 15 A$ Characteristics (Note 2) $V_{DS} = 10 V$, $I_D = 1 A$,Output Capacitance $V_{DS} = 10 V$, $I_D = 1 A$,Vurn-On Delay Time $V_{DS} = 4.5 V$, $R_{GEN} = 6 \Omega$ Turn-On Rise Time $V_{DS} = 15 V$, $I_D = 15 A$,Vurn-Off Fall Time $V_{DS} = 4.5 V$ Sate-Source Charge $V_{GS} = 4.5 V$ Sate-Drain Charge $V_{DS} = 15 V$, $I_D = 15 A$,Maximum Continuous Drain-Source Diode Forward CurrentDrain-Source Diode Forward $V_{DS} = 0 V$ Drain-Source Diode Forward $V_{DS} = 0 V$	DefinitionVoid of the termGate Voltage Drain Current $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ Gate-Body Leakage, Forward $V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$ Gate-Body Leakage, Reverse $V_{GS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate-Body Leakage, Reverse $V_{GS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate-Body Leakage, Reverse $V_{GS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate-Body Leakage, Reverse $V_{GS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate-Threshold Voltage $V_{DS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate Threshold Voltage $V_{DS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate Threshold Voltage $V_{DS} = -12 \text{ V} V_{DS} = 0 \text{ V}$ Gate Threshold Voltage $V_{DS} = 4.5 \text{ V}, I_D = 13 \text{ A}$ Characteristics $V_{GS} = 4.5 \text{ V}, I_D = 13 \text{ A}$ On-State Drain Current $V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$ Characteristics $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A}$ Characteristics(Note 2)furn-On Delay Time $V_{DS} = 10 \text{ V}, I_D = 1 \text{ A},$ furn-On Delay Time $V_{DS} = 10 \text{ V}, I_D = 1 \text{ A},$ furn-On Rise Time $V_{DS} = 10 \text{ V}, I_D = 1 \text{ A},$ furn-Onf Fall Time $V_{DS} = 15 \text{ V}, R_{GEN} = 6 \Omega$ furn-Off Fall Time $V_{OS} = 4.5 \text{ V}$ Gate-Drain Charge $V_{SS} = 4.5 \text{ V}$ Gate-Drain Charge $V_{SS} = 4.5 \text{ V}$ Gate-Drain Charge $V_{SS} = 2 \text{ A}_{S} \text{ V}$ Gate-Drain Charge $V_{OS} = 10 \text{ V}, I_D = 15 \text{ A},$ $V_{GS} = 4.5 \text{ V}$ $V_{SS} = 4.5 \text{ V}$ Gate-Drain Charge $V_{SS} = 4.5 \text{ V}$ Gate-Drain	ControlVDDPartVDDPartVero Gate Voltage Drain CurrentVDD $V_{GS} = 12$ V, $V_{GS} = 0$ VSate-Body Leakage, Forward $V_{GS} = 12$ V, $V_{DS} = 0$ VSate-Body Leakage, ReverseVDD $V_{GS} = -12$ V, $V_{DS} = 0$ VSate-Body Leakage, Reverse $V_{GS} = -12$ V, $V_{DS} = 0$ VSate-Body Leakage, ReverseVDD $V_{GS} = -12$ V, $V_{DS} = 0$ VSate-SoreSate-SoreSate-Body Leakage, ReverseVDD $V_{GS} = -12$ V, $V_{DS} = 0$ VSate-SoreSate-SoreSate Threshold VoltageID 250 µA, Referenced to 25° C-4Sate Threshold VoltageID 250 µA, Referenced to 25° C-4Sate Threshold VoltageID 250 µA, Referenced to 25° C-4Sate Drain SourceVDD $V_{GS} = 4.5$ V, $I_D = 13$ A, $T_J = 125^{\circ}$ C11.5Sate Drain CurrentVDD $V_{DS} = 10$ V, $I_D = 14$ A6.8Son-State Drain CurrentVDD $V_{DS} = 10$ V, $I_D = 15$ A75Characteristics(Note 2)100 Hz550Sourput CapacitanceVDD ID Hz550Severse Transfer CapacitanceVDD100 Hz17Sum-On Delay TimeVDD $V_{DS} = 15$ V, $I_D = 15$ A, $I7$ 18Sum-Off Delay TimeVDD $V_{DS} = 4.5$ V918Sate-Source ChargeVDD $V_{DS} = 4.5$ V7.533Sate-Source Charge $V_{DS} = 15$ V, $I_D = 15$ A, $V_{SS} = 4.5$ V7.5Sate-Drain Charge $G.8$ 6.833Sate	DefinitionVDSPartVDSPart1Gero Gate Voltage Drain CurrentVDS24 V, VDS0 V1Sate-Body Leakage, ForwardVDS12 V, VDS0 V100Sate-Body Leakage, ReverseVDS12 V, VDS0 V-100Sate-Body Leakage, ReverseVDSVDS0 V-100Sate-Body Leakage, ReverseVDSVDS0 V-100Sate-Threshold VoltageID250 µA, Referenced to 25°C-4-4Sate Threshold VoltageVDS= 4.5 V, ID= 13 A, TJ==125°C11.516Sate Threshold VoltageVDS= 10 V, ID= 14 A6.88Son-State Drain CurrentVDS= 10 V, ID= 15 A75

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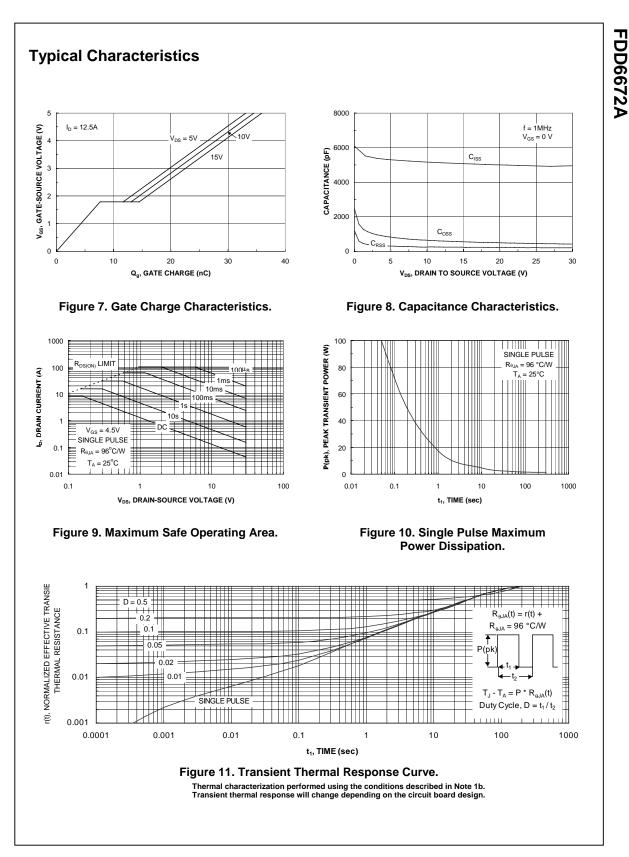




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